

AP88N30W-VB Datasheet

N-Channel 500V(D-S) Super Junction Power MOSFET

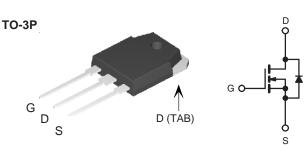
PRODUCT SUMMARY						
V _{DS} (V) at T _J max.	500					
R _{DS(on)} at 25 °C (Ω)	V _{GS} = 10 V	0.050				
Q _g max. (nC)	263					
Q _{gs} (nC)	41					
Q _{gd} (nC)	72					
Configuration	Single					

FEATURES

- Low figure-of-merit (FOM) $R_{on} \times Q_g$
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	- v	
Gate-Source Voltage	V _{GS}	± 30				
Continuous Drain Current (T _J = 150 °C)	N	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	- I _D -	47	А	
	V _{GS} at 10 V	T _C = 100 °C		30		
Pulsed Drain Current ^a			I _{DM}	139	1	
Linear Derating Factor				3.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	1410	mJ	
Maximum Power Dissipation	P _D	387	W			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	T _J = 125 °C		-10//-11	37	N// an	
Reverse Diode dV/dt ^d			dV/dt	9	V/ns	
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 $\Omega,\,I_{AS}$ = 10 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D,\, dI/dt$ = 100 A/µs, starting T_J = 25 °C.





PARAMETER	SYMBOL	TYP.	MAX		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 40						
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.3		°C/W			
SPECIFICATIONS (T _J = 25 °C, u	nless otherw	ise noted)						
PARAMETER	SYMBOL		T CONDITIONS	MIN.	TYP.	MAX.		
Static	0111201					10.00	0.11	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = 250 \mu A$		500	-	-	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J		$V_{GS} = 0.7, I_D = 2.50 \mu A$ Reference to 25 °C, I _D = 1 mA		0.70	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		2	-	4	V	
	GS(th)	$V_{DS} = V_{GS}, I_D = 250 \mu A$ $V_{GS} = \pm 20 V$		-	_	± 100	nA	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$			_	± 100	μΑ	
Zero Gate Voltage Drain Current			= 500 V, V _{GS} = 0 V	-	-	1	μΑ	
	I _{DSS}		$V_{\rm r}, V_{\rm GS} = 0 V, T_{\rm J} = 125 ^{\circ}{\rm C}$	-	-	25	μA	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$		-	0.050	-	Ω	
Forward Transconductance	g _{fs}		= 30 V, I _D = 24 A	-	16.7	-	S	
Dynamic	010		, 5	-	1			
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz		-	5182	-	pF	
Output Capacitance	C _{oss}			-	251	-		
Reverse Transfer Capacitance	C _{rss}			-	1	-		
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V_{DS} = 0 V to 400 V, V_{GS} = 0 V		-	192	-		
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	665	-		
Total Gate Charge	Qg	$V_{GS} = 10 \text{ V}$ $I_D = 24 \text{ A}, V_{DS} = 400 \text{ V}$		-	172	263	nC	
Gate-Source Charge	Q _{gs}			-	41	-		
Gate-Drain Charge	Q _{gd}			-	72	-		
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 400 \text{ V}, \text{ I}_D = 6 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_g = 9.1 \Omega$		-	37	84	- ns	
Rise Time	t _r			-	77	121		
Turn-Off Delay Time	t _{d(off)}			-	156	234		
Fall Time	t _f			-	93	196		
Gate Input Resistance	Rg	f = 1 MHz, open drain		-	0.64	-	Ω	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	47	A	
Pulsed Diode Forward Current	I _{SM}			-	-	139		
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V		-	0.9	1.2	V	
Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 24 \text{ A},$ $dI/dt = 100 \text{ A}/\mu\text{s}, V_{R} = 25 \text{ V}$		-	753	1506	ns	
Reverse Recovery Charge	Q _{rr}			-	14	28	μC	
Reverse Recovery Current	I _{RRM}			-	28	-	A	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

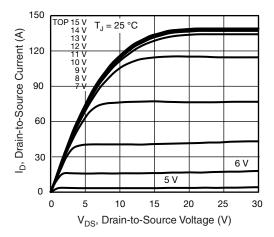


Fig. 1 - Typical Output Characteristics

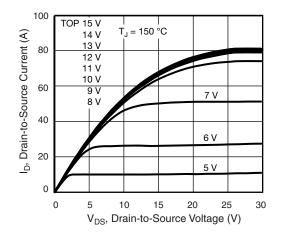


Fig. 2 - Typical Output Characteristics

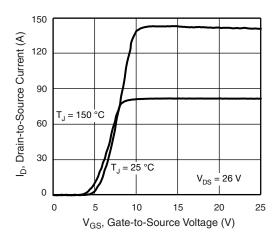


Fig. 3 - Typical Transfer Characteristics

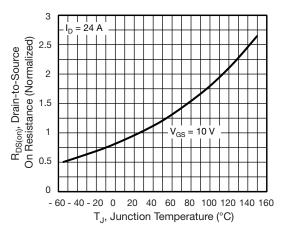


Fig. 4 - Normalized On-Resistance vs. Temperature

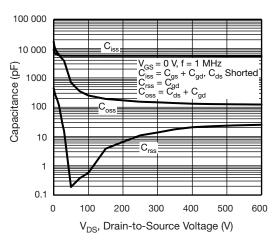


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

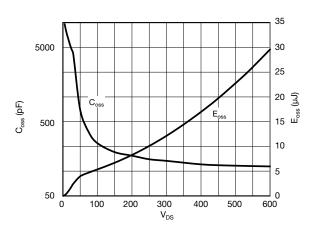


Fig. 6 - Coss and Eoss vs. VDS

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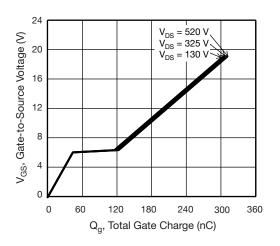


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

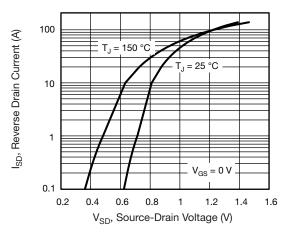


Fig. 8 - Typical Source-Drain Diode Forward Voltage

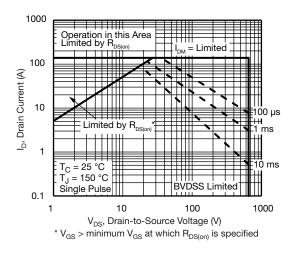
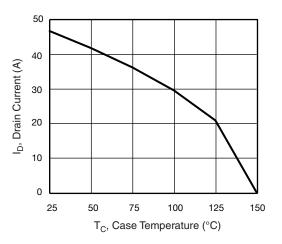


Fig. 9 - Maximum Safe Operating Area



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Fig. 10 - Maximum Drain Current vs. Case Temperature

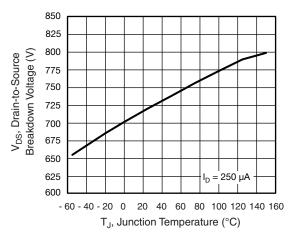
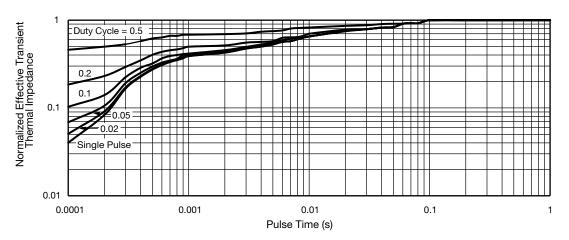


Fig. 11 - Temperature vs. Drain-to-Source Voltage

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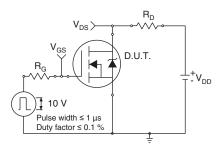


Fig. 13 - Switching Time Test Circuit

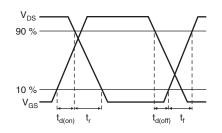


Fig. 14 - Switching Time Waveforms

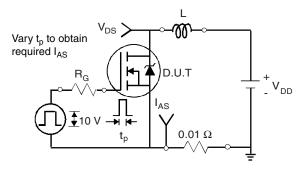


Fig. 15 - Unclamped Inductive Test Circuit

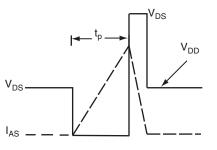


Fig. 16 - Unclamped Inductive Waveforms

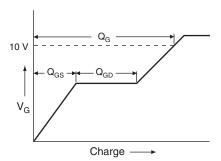


Fig. 17 - Basic Gate Charge Waveform

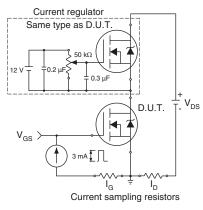


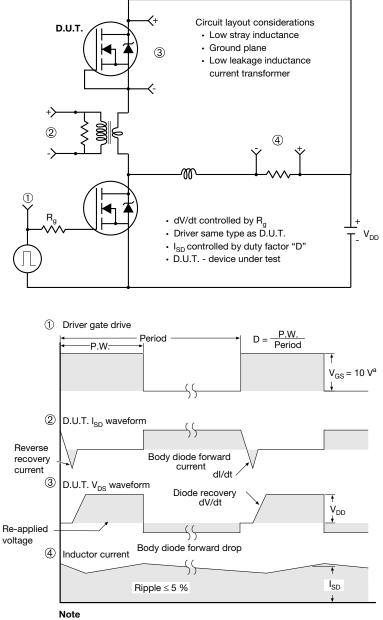
Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5 V$ for logic level devices

Fig. 19 - For N-Channel



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